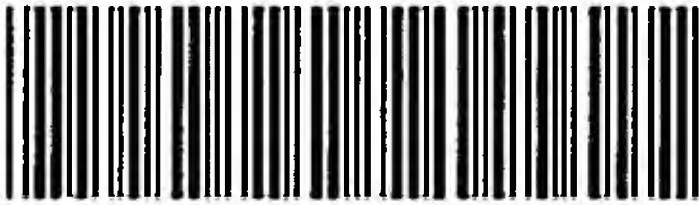


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,684	CHEN ET AL.	
	Examiner	Art Unit	
	Tuan Quach	2826	

SEARCHED			
Class	Subclass	Date	Examiner
257	685-687, 712, 713, 717, 777	1/17/2006	TQ
257	778, 787	1/17/2005	TQ
(update	search)		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PBPUB text search - see interference search printout		1/17/2006	TQ

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT; USPGPUB; EPO; JPO; DERWENT, IBMTDB) see search history	1/17/2006	TQ
EAST - USPGPUB text search - see interference search printout	1/17/2006	TQ